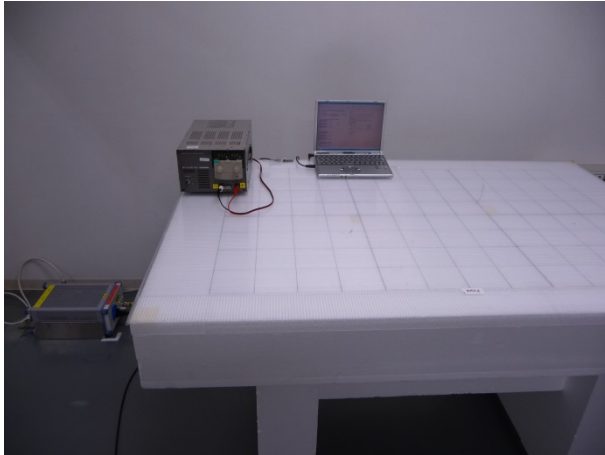


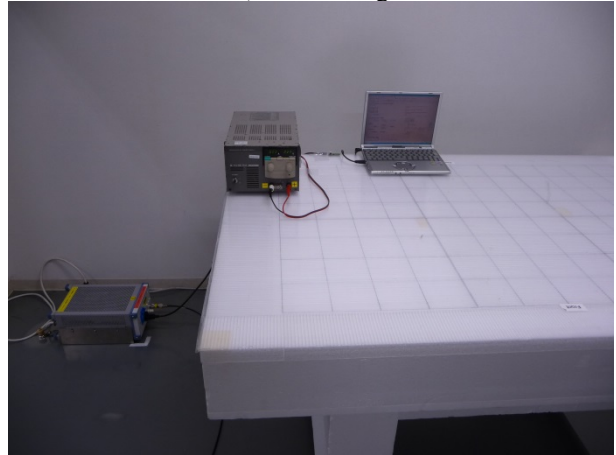
APPENDIX 3: Photographs of test setup

Conducted Emission

BTLE

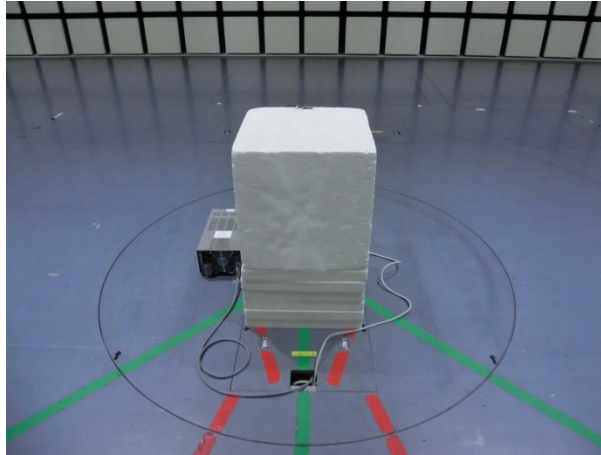


ANT, Nordic Original

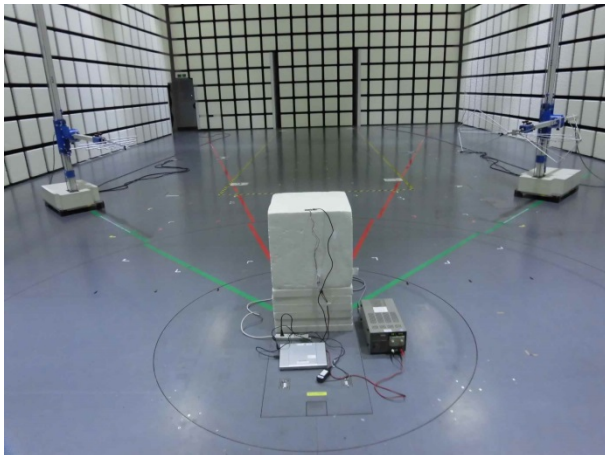


Radiated Spurious Emission (1/2)

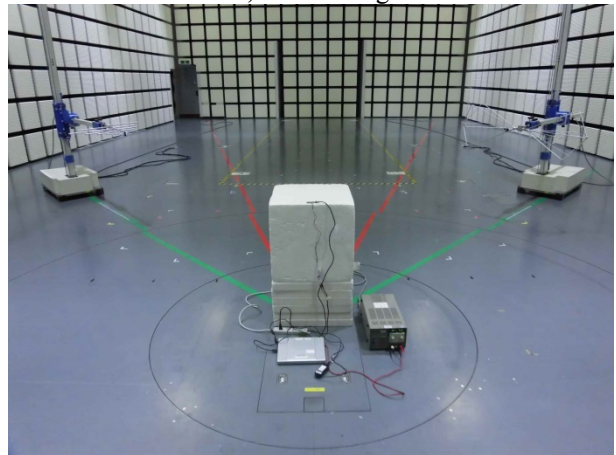
Below 1 GHz
Front



BTLE

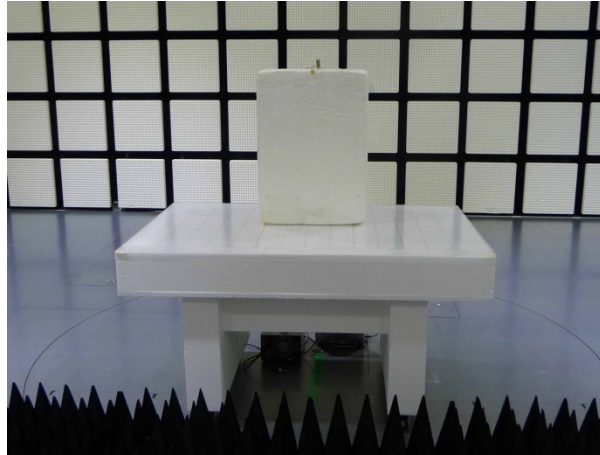


ANT, Nordic Original

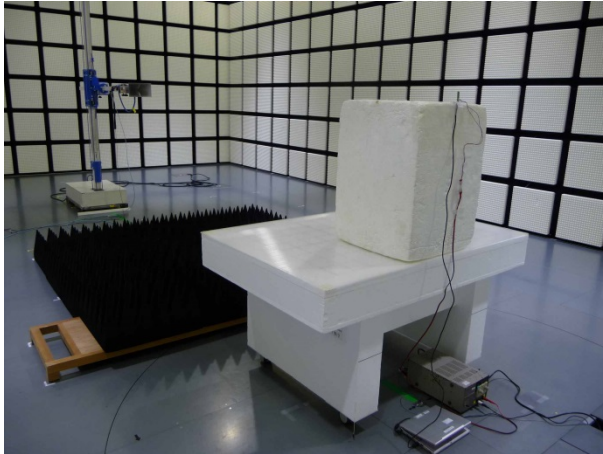


Radiated Spurious Emission (2/2)

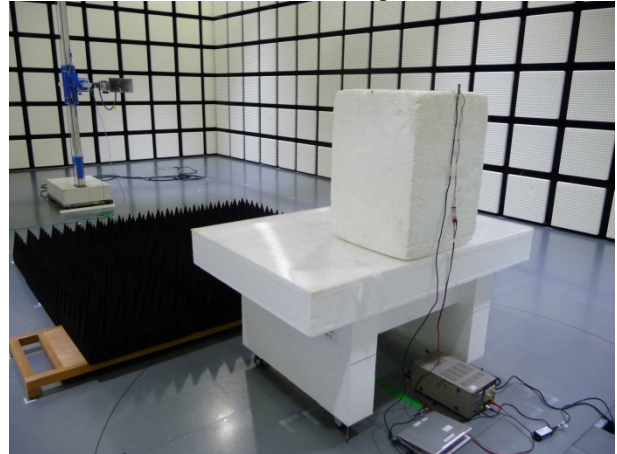
Above 1 GHz
Front



BTLE

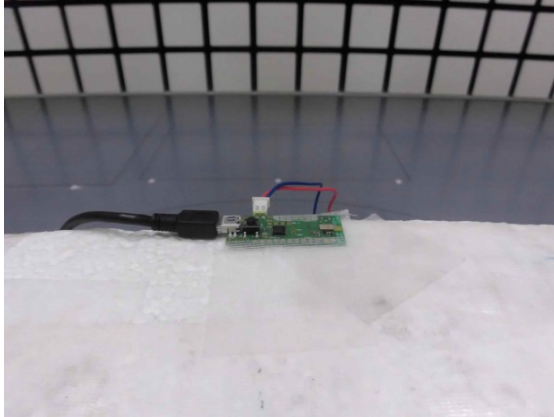


ANT, Nordic Original



Worst Case Position

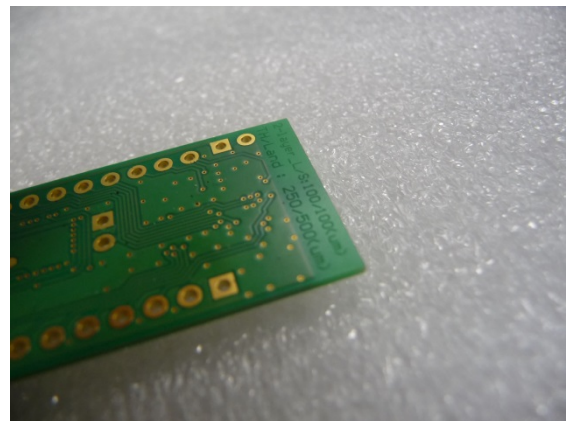
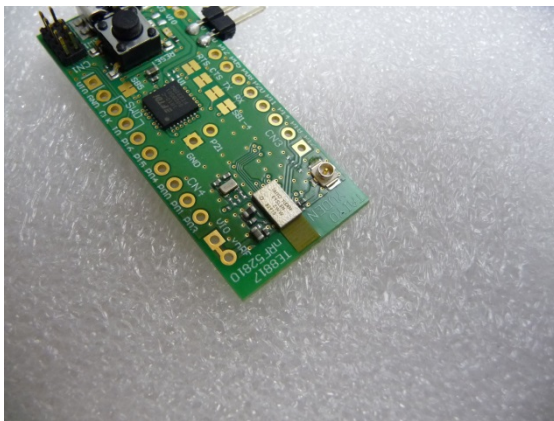
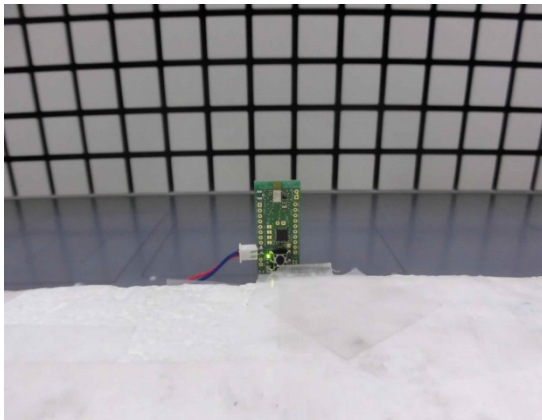
X-axis



Y-axis



Z-axis



*Use the motherboard with no metal plate, therefore this motherboard does not affect the module test condition.

End of Report

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